

DB22320 (Tentative)

Silicon epitaxial planar type

For rectification

■ Packaging

Embossed type (Thermo-compression sealing): 3000 pcs / reel (standard)

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Reverse voltage	V_R	30	V
Repetitive peak reverse voltage	V_{RRM}	30	V
Forward current (Average)	$I_{F(AV)}$	1.5	A
Non-repetitive peak forward surge current *	I_{FSM}	30	A
Junction temperature	T_j	125	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +125	$^\circ\text{C}$

Note) *: 50 Hz sine wave 1 cycle (Non-repetitive peak current)

■ Package

- Code
Mini2-F4-B
- Pin Name
1: Cathode
2: Anode

■ Marking Symbol: B5

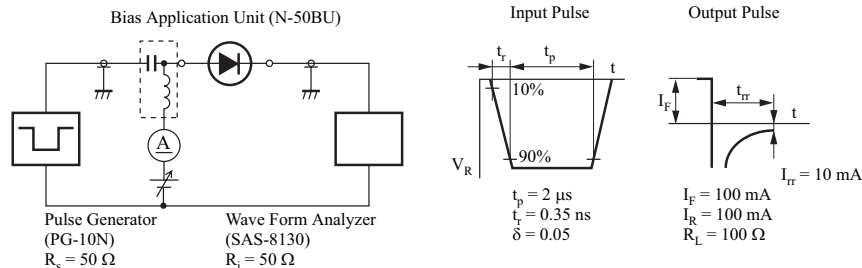
■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Forward voltage	V_{F1}	$I_F = 0.5 \text{ A}$			0.38	V
	V_{F2}	$I_F = 1.0 \text{ A}$			0.42	
Reverse current	I_R	$V_R = 30 \text{ V}$			100	μA
Terminal capacitance	C_t	$V_R = 10 \text{ V}, f = 1 \text{ MHz}$		47		pF
Reverse recovery time *	t_{rr}	$I_F = I_R = 100 \text{ mA}, I_{tr} = 0.1 \times I_R,$ $R_L = 100 \Omega$		15		ns

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

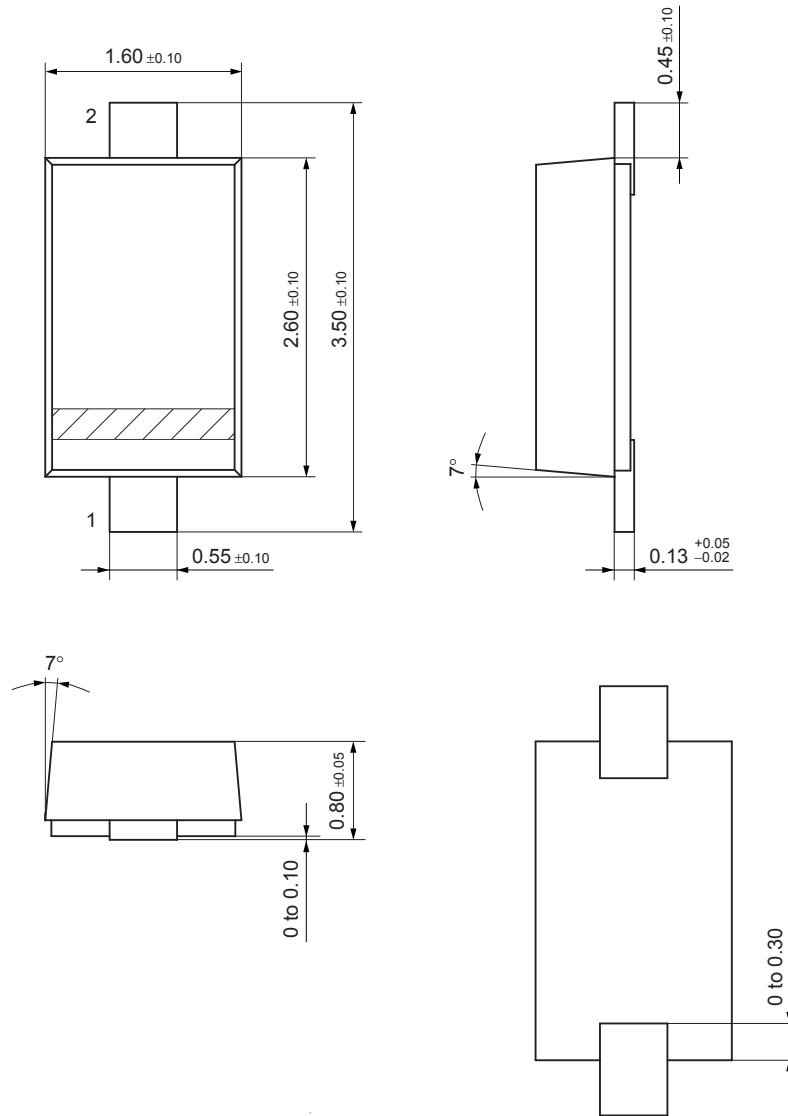
2. This product is sensitive to electric shock (static electricity, etc.). Due attention must be paid on the charge of a human body and the leakage of current from the operating equipment.

3. *: t_{rr} measurement circuit



Mini2-F4-B

Unit: mm



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